



# N-channel 30 V, 0.019 Ω typ., 8 A, P-channel 30 V, 0.024 Ω typ., 6 A STripFET<sup>TM</sup> Power MOSFET in a SO-8 package

Datasheet - preliminary data

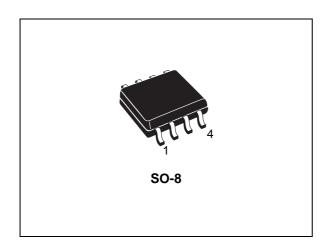
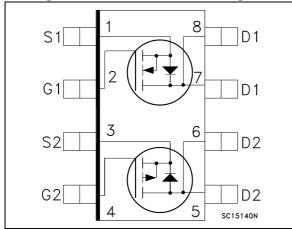


Figure 1. Internal schematic diagram



#### **Features**

Order code	Channel	V <sub>DS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
CTC0C6H3LL	Ν	30 V	0.021 Ω	8 A
STS8C6H3LL	Р	30 V	0.030 Ω	5 A

- STripFET™V N-channel Power MOSFET
- STripFET™VI DeepGATE™ P-channel Power MOSFET
- R<sub>DS(on)</sub>\* Q<sub>q</sub> industry benchmark
- Extremely low on-resistance R<sub>DS(on)</sub>
- High avalanche ruggedness
- · Low gate drive power losses

#### **Applications**

· Switching applications

#### **Description**

This device is a complementary pair transistor. The P-channel Power MOSFET is developed using STripFET™VI DeepGATE™ and the N-channel using the STripFET™ V technology. The resulting device exhibits low on-state resistance and an FOM among the lowest in its voltage class.

**Table 1. Device summary** 

Order code	Marking	Package	Packaging
STS8C6H3LL	86DK3L	SO-8	Tape and reel

Note: For the P-channel MOSFET actual polarity of voltages and current has to be reversed.

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STS8C6H3LL Electrical ratings

## 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Val	ue	Unit
Symbol	Faranteter	N-channel	P-channel	Offic
V <sub>DS</sub>	Drain-source voltage (v <sub>gs</sub> = 0)	30	)	V
$V_{GS}$	Gate- source voltage	+2	.0	V
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25°C single operating	8	6	А
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100°C single operating	5 3.7		А
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	32	24	Α
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25°C	2.7		W
T <sub>stg</sub>	Storage temperature	-55 to 150		°C
T <sub>j</sub>	Operating junction temperature	15	0	°C

<sup>1.</sup> Pulse width limited by safe operating area

Table 3. Thermal data

Symbo	Parameter	Value	Unit
R <sub>thj-pcb</sub>	Thermal resistance junction-ambient single operation	47	°C/W

<sup>1.</sup> When mounted on 1 inch<sup>2</sup> FR-4 board, 2 oz. Cu.,  $t \le 10$  sec

Note: For the P-channel MOSFET actual polarity of voltages and current has to be reversed

Electrical characteristics STS8C6H3LL

#### 2 Electrical characteristics

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Channel	Min.	Тур.	Max.	Unit
V	Drain-source	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0	N	30			V
V <sub>(BR)DSS</sub>	breakdown voltage	$ID = 230 \mu A, VGS = 0$	Р	30			V
		V <sub>DS</sub> = 30 V	N			1	μA
lana	Zero gate voltage	VDS - 30 V	Р			'	μΛ
I <sub>DSS</sub>	drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> =30 V, T <sub>C</sub> =125 °C	N			10	
		V <sub>DS</sub> =30 v, 1 <sub>C</sub> =123 C	Р			10   1	μA
1	Gate-body leakage	V <sub>GS</sub> = ±20 V	N			±100	nA
I <sub>GSS</sub>	current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ±20 V	Р			±100	IIA
V	Gate threshold voltage	VV I 250 uA	N	1			V
V <sub>GS(th)</sub>	Gate tilleshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	Р	'			V
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 3 A	N		0.019	0.021	Ω
D	Static drain-source	VGS - 10 V, ID = 3 A	Р		0.024	0.030	Ω
R <sub>DS(on)</sub>	on-resistance	V = 45 V   = 3 A	N		0.023	0.028	Ω
		$V_{GS} = 4.5 \text{ V}, I_{D} = 3 \text{ A}$	Р		0.038	0.050	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Channel	Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		N	-	475	-	pF
Oiss	input capacitance		Р	-	1450	-	pF
C	Output capacitance	V <sub>DS</sub> = 24 V, f = 1 MHz,	N	-	97	-	pF
C <sub>oss</sub>	Output capacitance	$V_{GS} = 0$	Р	-	178	-	pF
	Reverse transfer		N	-	19	-	pF
C <sub>rss</sub>	capacitance		Р	-	120	-	pF
	Total gate charge		N	-	4.6	-	nC
$Q_g$	Total gate charge		Р	-	12	-	nC
	Cata agurag abarga	V <sub>DD</sub> =24 V, I <sub>D</sub> =6 A	N	-	1.7	-	nC
$Q_{gs}$	Gate-source charge	V <sub>GS</sub> = 4.5 V (see Figure 25)	Р	-	4.4	-	nC
0	Cata drain abarga		N	-	1.9	-	nC
Q <sub>gd</sub>	Gate-drain charge		Р	-	5	-	nC

Note: For the P-channel MOSFET actual polarity of voltages and current has to be reversed



Table 6. Switching times

Symbol	Parameter	Test conditions	Channel	Min.	Тур.	Max.	Unit
<b>f</b>	Turn-on delay time		N	-	4	-	ns
t <sub>d(on)</sub>	Turn-on delay time		Р	-	15	-	ns
+	Rise time		N	-	22	-	ns
t <sub>r</sub>	Rise time	$V_{DD} = 24 \text{ V}, I_{D} = 3 \text{ A}$ $R_{G}=4.7 \Omega, V_{GS} = 10 \text{ V}$	Р	-	15	-	ns
+	Turn off dolay time	Figure 24	N	-	13	-	ns
t <sub>d(off)</sub>	Turn-off delay time		Р	-	24	-	ns
+	t <sub>f</sub> Fall time		N	-	2.8	-	ns
Ч			Р	-	21	-	ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Channel	Min.	Тур.	Max.	Unit
1.	Source-drain current		N	-		8	Α
I <sub>SD</sub>	Source-drain current		Р	-		6	Α
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current		N	-		32	Α
'SDM `	(pulsed)		Р	ı		24	Α
V <sub>SD</sub> (2)	Forward on voltage	Forward on voltage $I_{SD} = 6A, V_{GS} = 0$ P	N	-		1.1	V
V SD \	Porward on voltage		Р	-		1.1	V
	Reverse recovery		N	-	16.2		ns
t <sub>rr</sub>	time		Р	-	15		ns
0	Reverse recovery	I <sub>SD</sub> = 5 A, di/dt = 100 A/μs   V <sub>DD</sub> =16 V, T <sub>i</sub> =150 °C	N	-	8.1		nC
Q <sub>rr</sub>	charge	Figure 26	Р	-	6.5		nC
1	Reverse recovery		N	-	1		Α
IRRM	current		Р	-	0.9		Α

<sup>1.</sup> Pulse width limited by safe operating area.

Note: For the P-channel MOSFET actual polarity of voltages and current has to be reversed

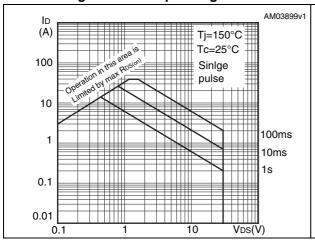
<sup>2.</sup> Pulsed: Pulse duration =  $300 \mu s$ , duty cycle 1.5%

Electrical characteristics STS8C6H3LL

## 2.1 Electrical characteristics (curves) for N-channel

Figure 2. Safe operating area

Figure 3. Thermal impedance



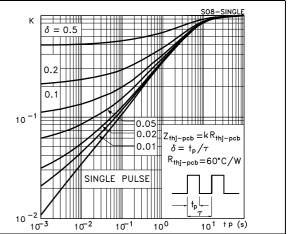
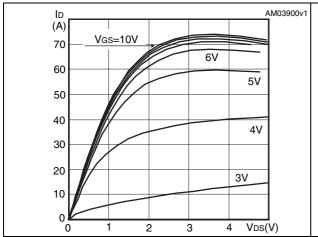


Figure 4. Output characteristics

Figure 5. Transfer characteristics



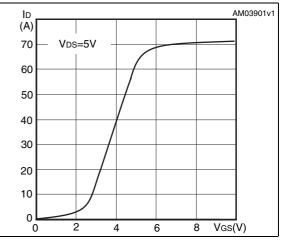
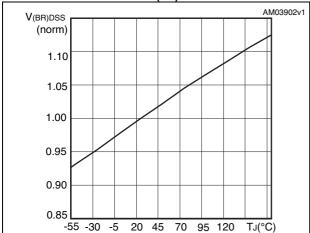


Figure 6. Normalized  $V_{(BR)DSS}$  vs temperature

Figure 7. Static drain-source on-resistance



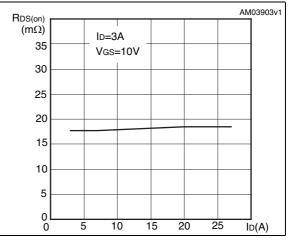


Figure 8. Gate charge vs gate-source voltage

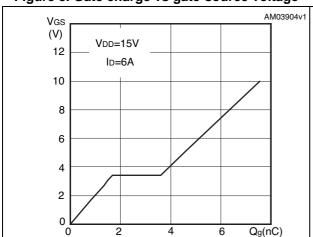


Figure 9. Capacitance variations

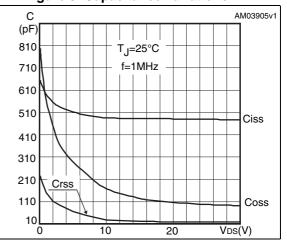
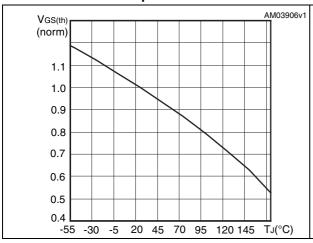


Figure 10. Normalized gate threshold voltage vs temperature

Figure 11. Normalized on-resistance vs temperature



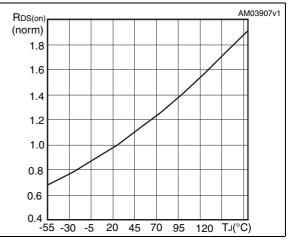
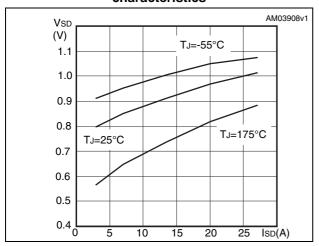


Figure 12. Source-drain diode forward characteristics



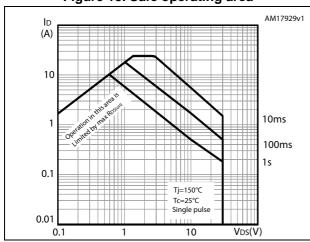


Electrical characteristics STS8C6H3LL

#### 2.2 Electrical characteristics (curves) for P-channel

Figure 13. Safe operating area

Figure 14. Thermal impedance



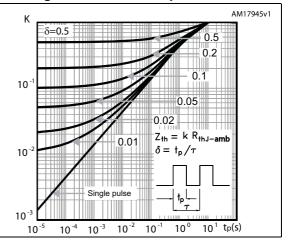
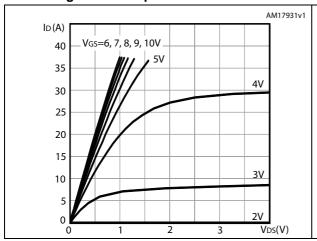


Figure 15. Output characteristics

Figure 16. Transfer characteristics



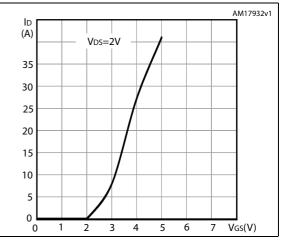
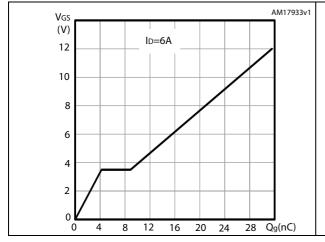
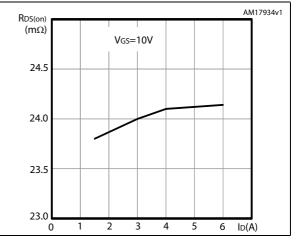


Figure 17. Gate charge vs gate-source voltage

Figure 18. Static drain-source on-resistance



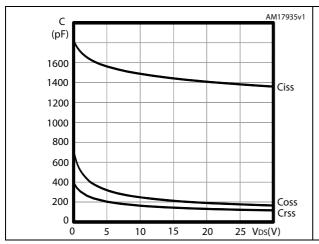


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Figure 19. Capacitance variations

Figure 20. Normalized gate threshold voltage vs temperature



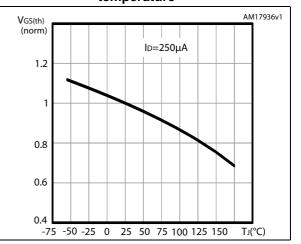
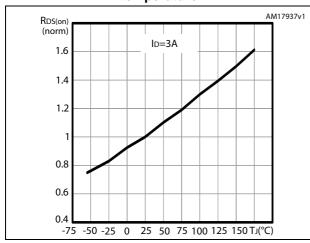


Figure 21. Normalized on-resistance vs temperature

Figure 22. Normalized  $V_{(BR)DSS}$  vs temperature



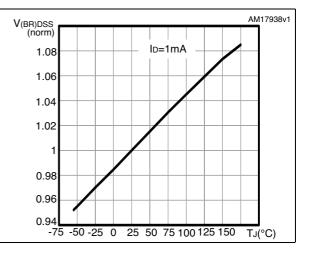
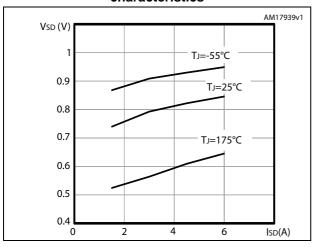


Figure 23. Source-drain diode forward characteristics





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#### 3 Test circuits for N-channel

Figure 24. Switching times test circuit for resistive load

Figure 25. Gate charge test circuit

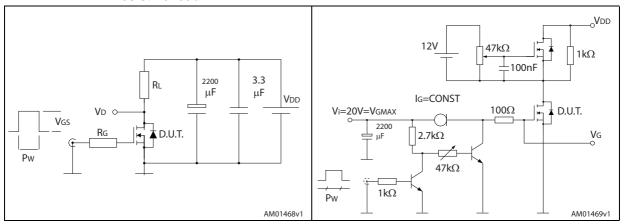


Figure 26. Test circuit for inductive load switching and diode recovery times

Figure 27. Unclamped inductive load test circuit

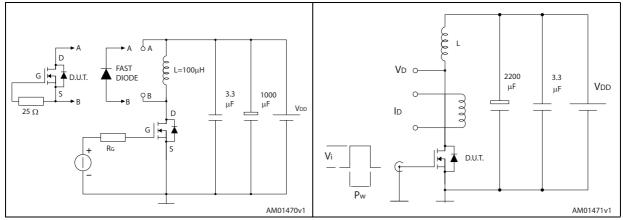
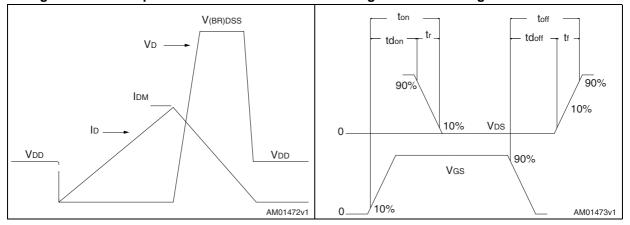


Figure 28. Unclamped inductive waveform

Figure 29. Switching time waveform



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## 4 Test circuits for P-channel

Figure 30. Switching times test circuit for resistive load

Figure 31. Gate charge test circuit

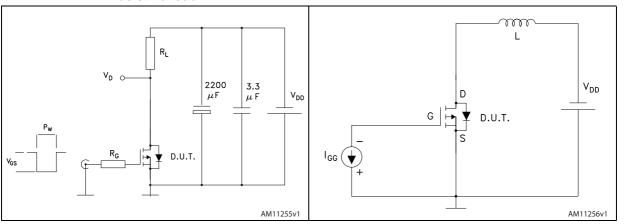
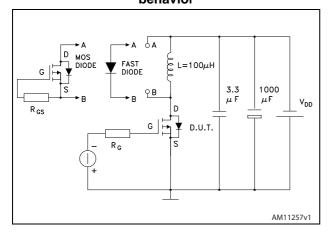


Figure 32. Test circuit for diode recovery behavior





# 5 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: <a href="https://www.st.com">www.st.com</a>. ECOPACK<sup>®</sup> is an ST trademark.

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SECTION B-B

SECTION B-B

SECTION B-B

SECTION B-B

O016023\_G\_FU

Figure 33. SO-8 drawing



Table 8. SO-8 mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
А			1.75
A1	0.10		0.25
A2	1.25		
b	0.31		0.51
b1	0.28		0.48
С	0.10		0.25
c1	0.10		0.23
D	4.80	4.90	5.00
E	5.80	6.00	6.20
E1	3.80	3.90	4.00
е		1.27	
h	0.25		0.50
L	0.40		1.27
L1		1.04	
L2		0.25	
k	0°		8°
ccc			0.10

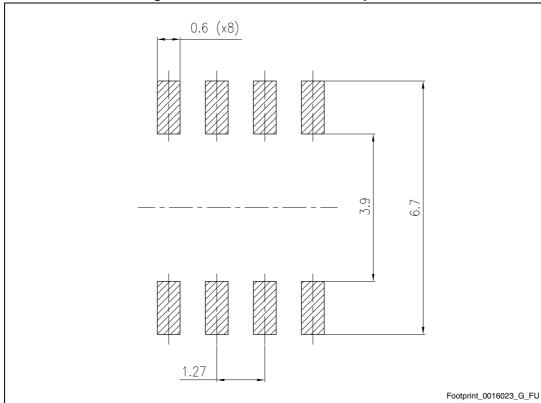


Figure 34. SO-8 recommended footprint<sup>(a)</sup>

a. All dimensions are in millimeters.



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## 6 Packaging mechanical data

A P Note: Drawing not in scale

Figure 35. SO-8 tape and reel dimensions

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Table 9. SO-8 tape and reel mechanical data

Dim		mm				
Dim.	Min.	Тур.	Max.			
Α			330			
С	12.8		13.2			
D	20.2					
N	60					
Т			22.4			
Ao	8.1		8.5			
Во	5.5		5.9			
Ko	2.1		2.3			
Po	3.9		4.1			
Р	7.9		8.1			



Revision history STS8C6H3LL

# 7 Revision history

Table 10. Revision history

Date	Revision	Changes
01-Feb-2013	1	First revision.
03-Apr-2014	2	<ul> <li>Modified: V<sub>GS</sub> (for P-channel) value in <i>Table 2</i></li> <li>Modified: P<sub>TOT</sub> value in <i>Table 2</i></li> <li>Modified: R<sub>thj-pcb</sub> value in <i>Table 3</i></li> <li>Modified: Q<sub>g</sub> typical value in <i>Table 5</i></li> <li>Added: Section 2.1: Electrical characteristics (curves) for N-channel and Section 2.2: Electrical characteristics (curves) for P-channel</li> <li>Minor text changes</li> </ul>
11-Apr-2014	3	<ul><li>Modified: marking in <i>Table 1</i></li><li>Minor text changes</li></ul>



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